WHAT IS CLAIMED IS:

- 1. A method for the preparation of a composition for electroplating a copper-containing layer on a substrate, comprising the steps of:
- 5 (i) providing an aqueous solution comprising at least:
 - a source of copper Cu (II) ions,
 - an additive to adjust the pH to a predetermined value, and
 - a complexing agent for complexing Cu (II) ions, said complexing agent having the chemical formula:

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COOR₁-COHR₂R₃

wherein R_1 is an organic group covalently bound to the carboxylate group (COO), R_2 is either hydrogen or an organic group, and

- 15 R₃ is either hydrogen or an organic group, said solution comprising no reducing agent,
 - (ii) providing electrons from a source not being in direct contact with said solution, through transport means providing contact between said source and said solution.
- 2. A method according to claim 1, wherein the source supplying20 electrons is placed in said solution.
 - 3. A method according to claim 2, wherein the source supplying electrons is a current generator or a battery.
 - **4.** A method according to claim 3, wherein the transport means comprise electrodes bound to wires.
- 5. A method according to claim 2, wherein the source supplying electrons has a current density comprised between 0.32 mA/cm² to 3.82 mA/cm².
 - $\,$ 6 . A method according to claim 1, wherein R_2 is hydrogen and R_3 is an organic group.
- $\,$ 7 . A method according to claim 1, wherein R_2 is hydrogen and R_3 30 $\,$ is –CHOH-COOR1.
 - $8 \cdot A$ method according to claim 1, wherein R_1 is a hydrocarbon group.
 - 9. A method according to claim 1, wherein said complexing agent is selected from the group consisting of L-diethyltartrate, L-diisopropyltartrate, L-diethyltartrate, D-diethyltartrate, D-diethyltartrate,

diisopropyltartrate, D-dimethyltartrate, D-dibutyltartrate, D-diethyllactate and a mixture of any of the foregoing.

- 10. A method according to claim 1, wherein the source of copper Cu(II) ions in the solution is $CuSO_4.5H_2O$.
- 5 11. A method according to claim 1, wherein the additive to adjust the pH of the composition is [Me₄N]OH (TMAH).
 - 12. A method according to claim 1, wherein the pH of said composition is comprised between 11 and 13.5, more preferably between 12 and 13.5, more preferably between 12.3 and 13.3.
- 13. A Process for forming at least one copper-containing layer on a substrate comprising at least the step of electroplating a copper-containing layer onto said substrate in a first electroplating bath, wherein said electroplating bath is the composition prepared by the method according to any one of the preceding claims.
- 14. A process according to claim 13, wherein the temperature of the composition is comprised between 10°C and 50°C, preferably between room temperature and 45°C.
 - 15. A process according to claim 13, wherein said coppercontaining layer is formed directly on said substrate.
- 16. A process according to claim 13, wherein said coppercontaining layer is formed indirectly on said substrate after a pre-step of forming a primary layer on said substrate, so that said copper-containing layer is formed on said primary layer.
 - 17. A process according to claim 16, wherein said primary layer is a copper diffusion barrier layer.
- 25 18. A process according to claim 17, wherein said copper diffusion barrier layer is metal conductive or not.
 - 19. A process according to claim 18, wherein said copper diffusion barrier layer is selected from the group consisting of a Ti layer, a TiN layer, a TaN layer, a Co layer and a Co-alloy layer.
- 20. A process according to claim 13, wherein the resulting copper-containing layer is a copper seed layer.
 - 21. A process according to claim 20, further comprising the step of forming another copper-containing layer on the last formed copper seed layer using a second electroplating bath.

- 22. A process according to claim 21, wherein the second electroplating bath is the first electroplating bath used for forming the copper seed layer.
- 23. A process according to claim 21, wherein the second5 electroplating bath is a cupric-sulfuric acid-based electroplating bath.